

Notice of References Cited	Application/Control No. 10/530,402		Applicant(s)/Patent Under Reexamination EYTAN ET AL.	
	Examiner THOMAS D. ALUNKAL		Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,366,542	04-2002	Kojima et al.	369/44.23
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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